

FORM PTO-1449
(REV. 7-80)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.: 5032.1001

SERIAL NO.: To Be Assigned

LIST OF PRIOR ART CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT(S): Reiner JUNG

FILING DATE: Herewith

GROUP: To Be Assigned

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO
/CL/	AJ	9 9 3 9 1 8 4	Aug. 5, 1999	WO-WIPO				
	AK							
	AJ							
	AK							
	AL							
	AM							
	AN							
	AO							
	AP							

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AR	
	AS	
	AT	

EXAMINER

/Christopher Lavin/

DATE CONSIDERED

06/13/2007

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-148
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.: 5032.1001

SERIAL NO.: 10/726,925

LIST OF PRIOR ART CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT(S): Reiner JUNG

FILING DATE: 12/03/2003

GROUP: 2621

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER							DATE	NAME	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
/CL/	AA	6	4	2	9	9	3	6	Aug. 6, 2002	Scaduto	358	417	
/CL/	AB	4	7	6	1	0	7	5	Aug. 2, 1988	Matsushita et al.	358	39	
/CL/	AC	6	0	2	2	3	1	5	Feb. 8, 2000	Iliff	600	300	
/CL/	AD	5	1	0	7	4	2	2	Apr. 21, 1992	Kamentsky et al.	364	413.08	
/CL/	AE	6	7	0	7	5	4	8	Mar. 16, 2004	Kreimer et al.	358	301	
	AF												
	AG												
	AH												
	AI												

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
													YES	NO
/CL/	AJ	0	4	2	1	7	3	6	May 14, 1997	Europe			corresponds to US 5,107,422	
/CL/	AK	02	0	6	3	2	5	9	Aug. 15, 2002	WIPO			corresponds to US 6,707,548	
	AJ													
	AK													
	AL													
	AM													
	AN													

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	
	AP	
	AR	
	AS	

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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER								DATE	NAME	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
/CL/	AA	6	0	9	4	2	2	1		Jul. 25, 2000	Andersson	348	231	
	AB													
	AC													
	AD													
	AE													
	AF													
	AG													
	AH													
	AI													

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
														YES	NO
/CL/	AJ	20	00	30	7	9	2	6		Nov. 2, 2000	JP-Japan			X	
	AK														
	AJ														
	AK														
	AL														
	AM														
	AN														

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

/CL/	AD	"New Imaging Systems for Fluorescence Microscopy", Circle No. 349												
/CL/	AP	T.I.L.L. Photonics GmbH, "Real-Time Fluoreszenz Imaging und Photometrie", www.bayern.de/InnovationsMARKT/Aussteller/TILL/exponat.html , October 26, 1999												
/CL/	AR	T.I.L.L. Photonics GmbH, "T.I.L.L. Photonics GmbH", www.bayern.de/InnovationsMARKT/Aussteller/TILL/ , October 26, 1999												
	AS													

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